EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	37	324/758.ccls. and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:25
L3	162	324/754.ccls. and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:25
L4	22	324/158.1.ccls. and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:26
L5	38	324/765.ccls. and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:26
L6	280	"324"/$.ccls. and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:26
L7	28	probe adj card adj analyzer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:27
L8	7	scrub adj mark adj analyzer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:27
L9	7959	probe adj card	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:28
L10	37	9 and scrub adj mark	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:27

L11	292	9 and scrub	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/03/17 14:28

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	0	(probe same card same ayalyzer same scrub same mark same analyer same imaging same operative same obtain same images same first same scrub same pins same check same plate same second same bonding same pads same data same processor smae coupled same associated same pattern same allows same prediction same behavour same semiconductor same die same metalization).clm.	US-PGPUB	OR	ON	2006/03/17 14:24